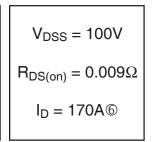
International Rectifier

IRFPS3810PbF

HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

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Description

The HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.



Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	170©	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	120©	Α
I _{DM}	Pulsed Drain Current ①	670	
P _D @T _C = 25°C	Power Dissipation	580	W
	Linear Derating Factor	3.8	W/°C
V _{GS}	Gate-to-Source Voltage	± 30	V
E _{AS}	Single Pulse Avalanche Energy®	1350	mJ
I _{AR}	Avalanche Current①	100	Α
E _{AR}	Repetitive Avalanche Energy①	58	mJ
dv/dt	Peak Diode Recovery dv/dt ③	2.3	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.26	
R _{θCS}	Case-to-Sink, Flat, Greased Surface	0.24		°C/W
$R_{\theta JA}$	Junction-to-Ambient		40	

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.11		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.009	Ω	V _{GS} = 10V, I _D = 100A ④
V _{GS(th)}	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = 10V, I_{D} = 250\mu A$
g _{fs}	Forward Transconductance	52			S	$V_{DS} = 50V, I_D = 100A$
lass	Drain-to-Source Leakage Current			25	- μA -	$V_{DS} = 100V, V_{GS} = 0V$
I _{DSS}	Brain to Godice Leakage Guiterit			250	μΑ]	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 30V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA .	$V_{GS} = -30V$
Qg	Total Gate Charge		260	390		I _D = 100A
Q _{gs}	Gate-to-Source Charge		49	74	nC	$V_{DS} = 80V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		160	250		V _{GS} = 10V⊕
t _{d(on)}	Turn-On Delay Time		24			$V_{DD} = 50V$
t _r	Rise Time		270			I _D = 100A
t _{d(off)}	Turn-Off Delay Time		45		ns	$R_G = 1.03\Omega$
t _f	Fall Time		140			V _{GS} = 10V ④
L _D	Internal Drain Inductance		5.0			Between lead,
					nH	6mm (0.25in.)
L _S	Internal Source Inductance		13			from package
						and center of die contact
C _{iss}	Input Capacitance		6790			$V_{GS} = 0V$
Coss	Output Capacitance		2470		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		990			f = 1.0MHz, See Fig. 5
Coss	Output Capacitance		10740			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
Coss	Output Capacitance		1180			$V_{GS} = 0V, V_{DS} = 80V, f = 1.0MHz$
Coss eff.	Effective Output Capacitance ©		2210			$V_{GS} = 0V$, $V_{DS} = 0V$ to $80V$

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			4700		MOSFET symbol	
	(Body Diode)			170⑥	Α Α	showing the	
I _{SM}	Pulsed Source Current			070	670		integral reverse
	(Body Diode) ①		670		p-n junction diode.		
V_{SD}	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C$, $I_S = 100A$, $V_{GS} = 0V$ ④	
t _{rr}	Reverse Recovery Time		220	330	ns	$T_J = 25^{\circ}C, I_F = 100A$	
Q _{rr}	Reverse RecoveryCharge		1640	2460	nC	di/dt = 100A/μs ④	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)					

Notes:

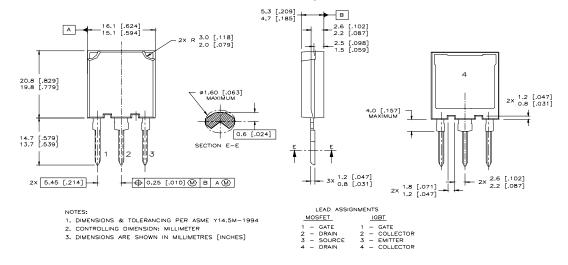
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^{\circ}C$, L = 0.27mH $R_G = 25\Omega$, $I_{AS} = 100A$. (See Figure 12)
- $\label{eq:loss_def} \ensuremath{ \Im \ I_{SD}} \leq 100 A, \ di/dt \leq 350 A/\mu s, \ V_{DD} \leq V_{(BR)DSS},$ یں ے ۱∪UA, T_J≤ 175°C 2
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- $\ensuremath{\mathbb{G}}$ C_{oss} eff. is a fixed capacitance that gives the same charging time as $C_{oss}\,\text{while}\,\,V_{DS}\,\text{is rising from 0 to 80\%}\,\,V_{DSS}$
- © Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 105A.

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International

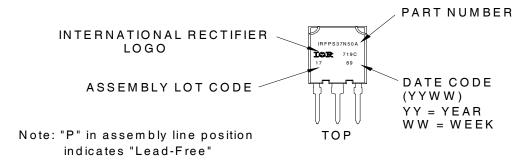
TOR Rectifier

Case Outline and Dimensions — Super-247



Super-247 (TO-274AA) Part Marking Information

EXAMPLE: THIS IS AN IRFPS37N50A WITH ASSEMBLY LOT CODE 1789 ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"



Data and specifications subject to change without notice.

This product has been designed and qualified for the Industrial market.

Qualification Standards can be found on IR's Web site.

